


<b>Search Notes</b> 	<b>Application/Control No.</b> 10585619	<b>Applicant(s)/Patent Under Reexamination</b> NINOMIYA ET AL.
	<b>Examiner</b> MEGAN ARNBERG	<b>Art Unit</b> 1796

SEARCHED			
Class	Subclass	Date	Examiner
525	400	2/28/2008	MCA
525	400	10/23/2008	MCM

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search -see printout	2/28/2008	MCA
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT) - see printout	2/28/2008	MCA
Updated Inventor name search -see printout	10/23/2008	MCM
Updated EASTsearch -see printout	10/23/2008	MCM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner, Art Unit 1796